## Application/Control No. Applicant(s)/Patent Under Reexamination 10/521,076 KRATZER ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 **David Sample** 1755 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α US-В С US-US-D US-Ε US-F US-G US-Н USı US-J US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY WO 9943717 A1 09-1999 World Intellect BOHNEN et al. Ν 0 Р Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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